


<b>Search Notes</b>  	<b>Application/Control No.</b>  10618227	<b>Applicant(s)/Patent Under Reexamination</b>  PAN ET AL.
	<b>Examiner</b>  Pathak, Sudhanshu C	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
375	260	2/3/2008	SP
	347		
	130		
	340		
	222		
370	210	2/3/2008	SP
	203		
711	5	2/3/2008	

SEARCH NOTES		
Search Notes	Date	Examiner
east	2/3/2008	SP
IEEE Xplore	2/3/2008	SP
Inventor Name Search	2/3/2008	
Sklar	9/10/2008	SP
Discuss w/Nader Bolorouchi regarding convolution and circular convolution	2/26/2009	SP
IEEE Xplore	4/3/2009	SP
east		
east	9/8/2009	SP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
375	139	9/8/2009	SP
	260		
	219		
	347		

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